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Software for tests: AMB and LAMB
configuration - Available tools

FTK Workshop – Pisa 13/03/2013

Outline

- ▶ VME standard protocol description
- ▶ AMBoard & LAMB configuration
- ▶ AMchip configuration and control
- ▶ Tools and software for testing

VME crate interface

▶ VME crate

- ▶ Link to the document for the VME protocol

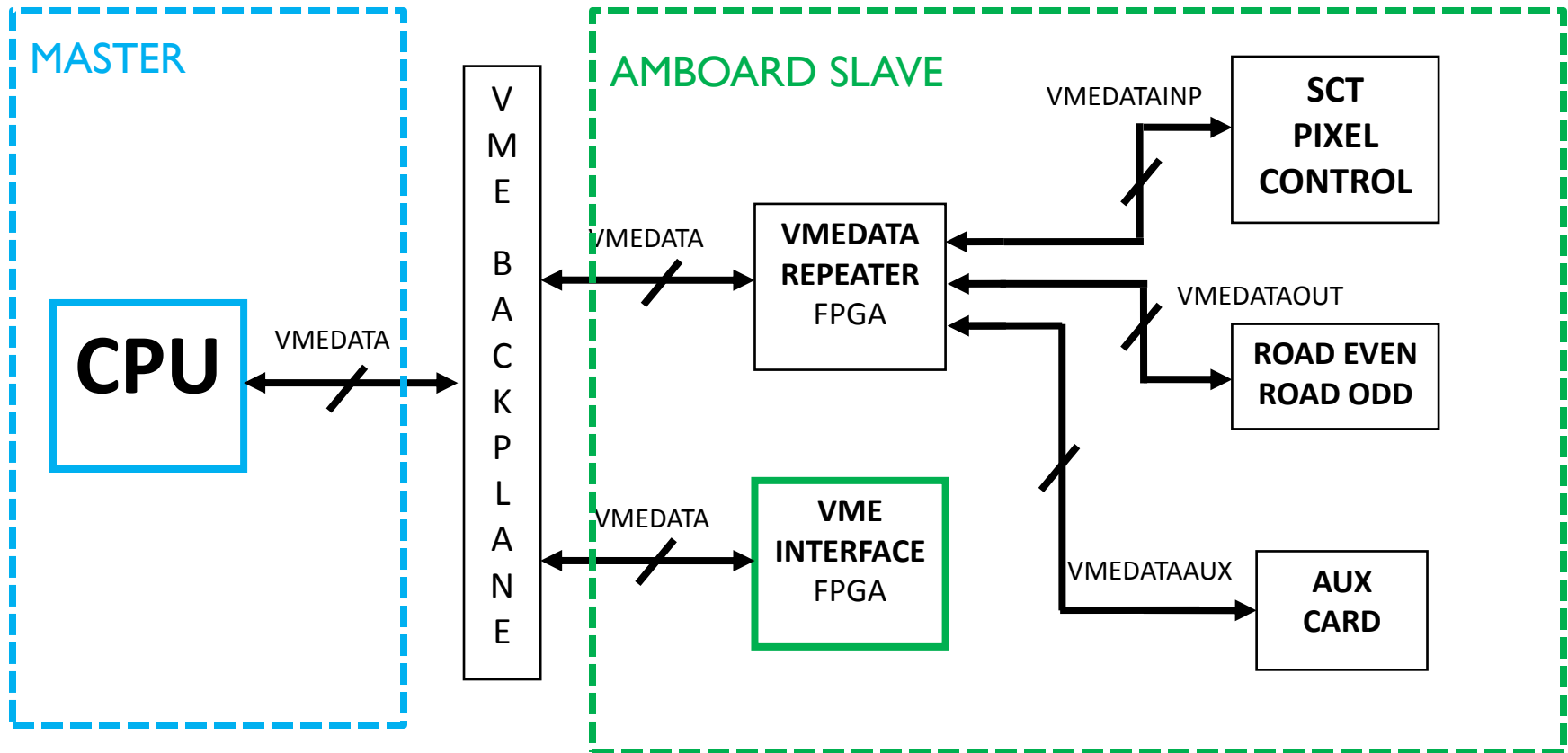
http://www.interfacebus.com/Design_Connector_VME.html

- ▶ 21 slot for the VME crate
- ▶ In the **first slot** there is the master CPU
- ▶ Until 20 slot for the AMBoard that is the slave
- ▶ A **geographical address** identifies the position of the board



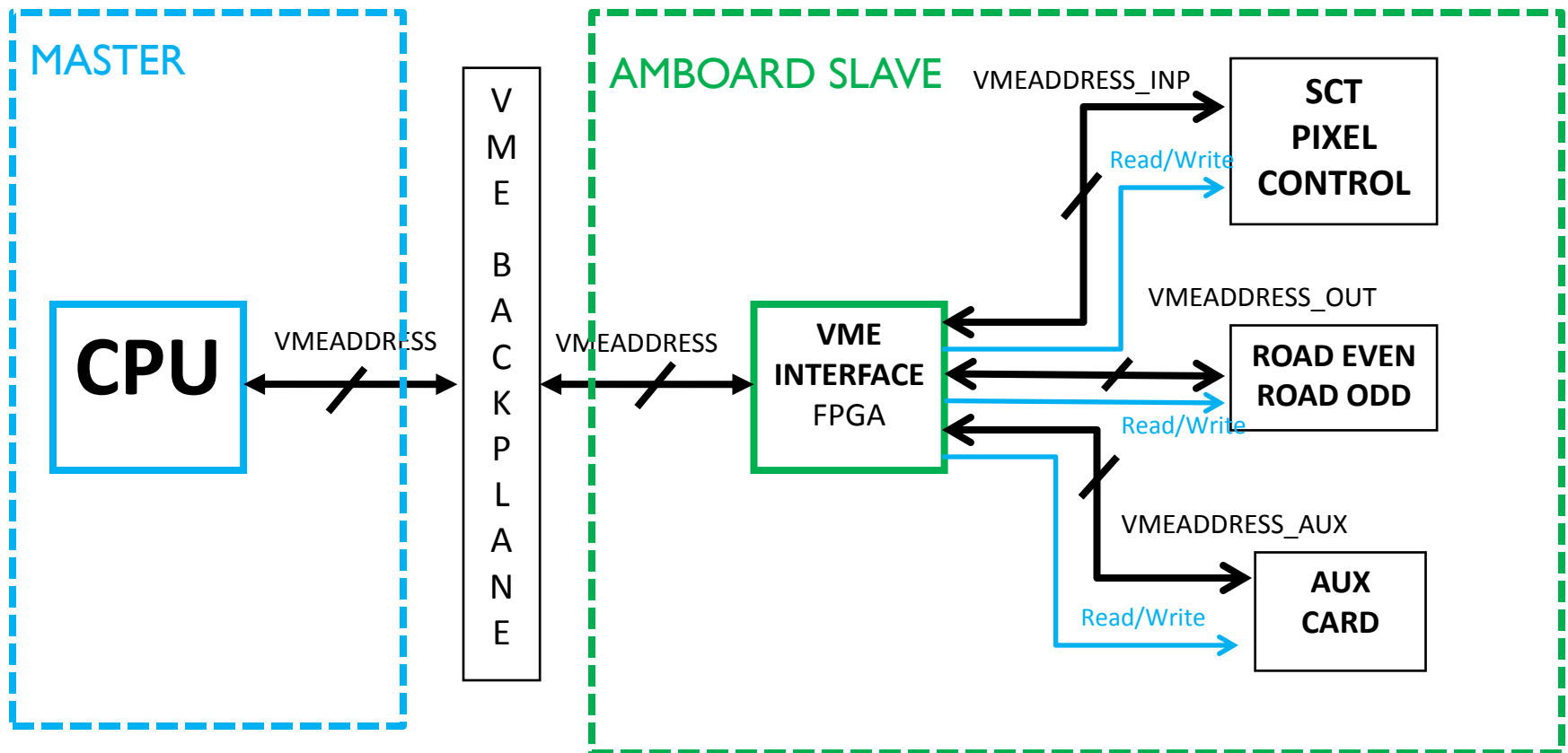
VME **data** distribution

- ▶ The VME data bus distribution inside the AMBoard



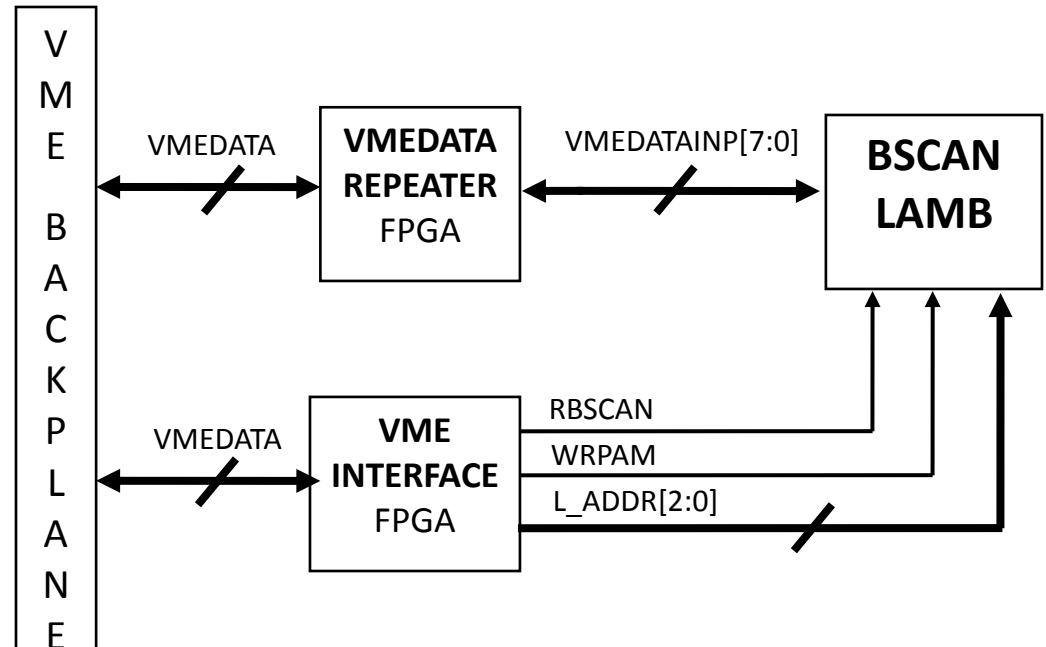
VME **address** distribution

- ▶ The VME address bus is distribute to all chip of the AMBoard with the Read/Write signal



LAMB configuration

- ▶ The VME data bus is also distributed to the all 4 LAMBs
 - ▶ 8 vmedata to each LAMB so each one is controlled in parallel
- ▶ The data is received from BSCAN chip that perform the conversion from VME to JTAG interface
 - ▶ There is 8 AMChip JTAG chain so each chain is controlled in parallel
 - ▶ A 3 bit address is received to identify the JTAG operation (write TDI o TMS read TDO)



Software for test

- ▶ The CPU master controls the VME protocol: function in C++ code are implemented

```
ftk@pcftkvmel1:~/testDaniel/ftk_v2/ftk_amb_ftk/src/low
/* define board */
vmeaddr =
ret = VME
if (ret != VME_SUCCESS)
{
    VME_ErrorPrint(ret);
    FTK_VME_ERROR( "writepatterns.cxx : Failed VME_Open " );
}

master_map.vmebus_address = vmeaddr;
master_map.window_size = 0x1000000;
master_map
master_map
ret = VME
if (ret != VME_SUCCESS)
{
    VME_ErrorPrint(ret);
    FTK_VME_ERROR( "writepatterns.cxx : Failed VME_MasterMap " );
}
```

VME_ReadSafeUInt (int master_mapping, u_int address_offset, u_int* value);

Read register of a specific location address

VME_WriteSafeUInt (int master_mapping, u_int address_offset, u_int value);

Write register of a specific location address

- ▶ All the functions are based on the basic read and write operation of a register

Software for test

- ▶ The principal operations with the software are
 - ▶ **Configure** and **control** the AMchips
 - ▶ **Testing the hardware** connection to/from AMchips with JTAG standard
 - ▶ **Readout** of the **SpyBuffer** and **writing** of **VmeFifo**
 - ▶ Automatic script to testing the entire system

AMChip pattern configuration

- ▶ Crate the map of the AMchip present into the board
 - ▶ A JTAG operation to define the mapping



Number of the LAMB
present in the board

Define the **active columns** present in each LAMB

Total number of AMchips

AMChip pattern configuration

- ▶ Crate the map of the AMchip present into the board
 - ▶ A JTAG operation to define the mapping
- ▶ Write the “**CONFIGURATION REGISTER**” of the AMchip

```
DEF_THR <= JPATT_CTRL (3 downto 0) := Threshold
DEF_required_layers <= JPATT_CTRL (5 downto 4);
GEOADDR <= JPATT_CTRL(14 downto 8) := geographical address
BOTTOMchip <= JPATT_CTRL(32) := input bus mirror
test_mode <= JPATT_CTRL(40);
enable_layermap <= JPATT_CTRL(44);
LASTchip <= JPATT_CTRL(48);
disable_PATT_FLOW <= JPATT_CTRL(52);
drive_strength <= JPATT_CTRL(60);
DCBits<=JPATT_CTRL(79 downto 64);
```

AMChip pattern configuration

- ▶ Crate the map of the AMchip present into the board
 - ▶ A JTAG operation to define the mapping
- ▶ Write the “**CONFIGURATION REGISTER**” of the AMchip
- ▶ Start the **writing pattern operation** into the AMchips
 - ▶ Write the value of the first address location into the **ADDRES_DATA** register
 - ▶ An iterative procedure on all the pattern
 - ▶ Write the pattern data into the **DATA REGISTER**
 - ▶ Send the **OPERATION_WRITE_INCREMENT** to write the pattern and increment the value of the **ADDRESS REGISTER**

AMChip pattern configuration

```
ftk@pcfthvml:~/testDaniel/ftk_v2/ftk_amb_ftk/src/low
ConfigureScam(aml, slot, chipno, active_columns, BYPASS, 1); /* goto Run-Test/Idle */

/* reset all patterns */

/* put all chips into LDADDR and write in 0*/
ConfigureScam(aml, slot, chipno, active_columns, LDADDR, 1); /* goto Run-Test/Idle */
GotoShiftDRfromIdle(aml, active_columns);
for (i=0; i<ADDR_SIZE*chainlength; i++)
    data[i] = 0;
AMshift(aml, slot, active_columns, ADDR_SIZE*chainlength, data, NULL, 1);
GotoIdlefromExit1(aml, active_columns);

/* put all chips into LDDATA */
ConfigureScam(aml, slot, chipno, active_columns, LDDATA, 1); /* goto Run-Test/Idle */
GotoShiftDRfromIdle(aml, active_columns);
for (i=0; i<DATA_SIZE*chainlength; i++)
    data[i] = 0;

AMshift(aml, slot, active_columns, DATA_SIZE*chainlength, data, NULL, 1);
GotoIdlefromExit1(aml, active_columns);

//read the data register
CheckOperation(aml, slot, chipno, active_columns, RDDATA, DATA_SIZE);

// Reset all the patterns
for (i=0; i<MAXPATT_PERCHIP; i++)
    ConfigureScam(aml, slot, chipno, active_columns, OPWRINC, 1); /* goto Run-Test/Idle */

ConfigureScam(aml, slot, chipno, active_columns, BYPASS, 1); /* goto Run-Test/Idle */

/* start to write the patterns */
```

Write the IR JTAG of AMchip

Write the data into the register addressing

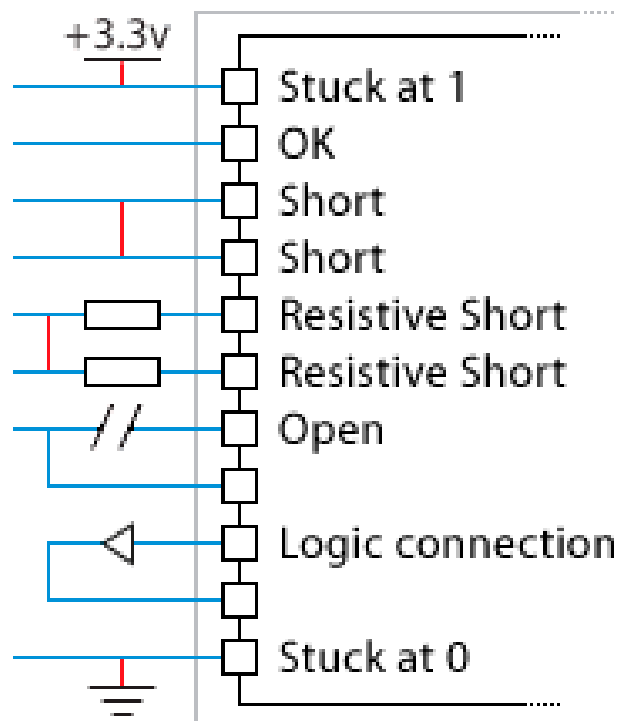
290,3 42%

AMChip configuration

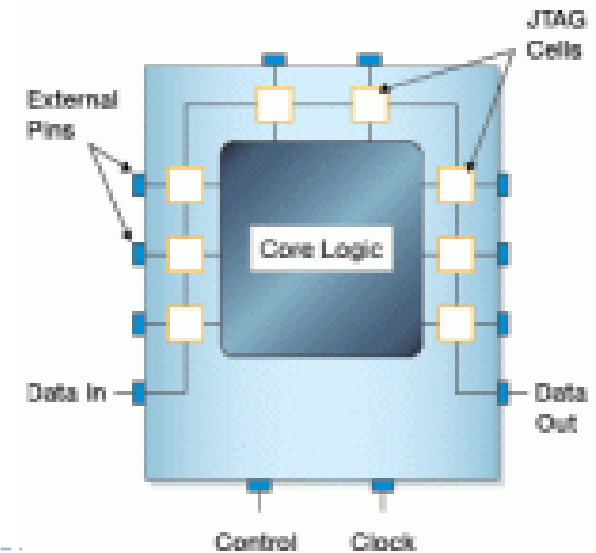
- ▶ **Check pattern** operation control the pattern bank written
 - ▶ This operation is done only with JTAG operation
 - ▶ Set the AMchip into TMODE operation so the input/output data is disable
 - ▶ Loading the pattern data into the **DATA REGISTER** of the AMchip
 - ▶ Send a **INIT_OPCODE** command to enable the match of the pattern
 - ▶ Control the **ADDRESS REGISTER** to compare the current value with the expecting value
 - ▶ Send an **SELECTION_BANK** command to clear the output match for the next pattern

LAMB JTAG Testing

- ▶ Testing with JTAG allows you to test printed circuit boards for manufacturing defects and functional failures



Chip manufacturers includes **special cell** on each of the ICs pins to facilitate test.



LAMB JTAG Testing

- ▶ Testing with JTAG allows you to test printed circuit boards for manufacturing defects and functional failures
 - ▶ By driving signals between connected devices, nets can be tested for opens, shorts and stuck-at failures.
- ▶ For testing all the pad of the AMchip we have to check
 - ▶ **INput DIstributor to input pad of AMchips [DONE]**
 - ▶ **AMchips output to GLUE [TO-DO]**
 - ▶ **AMchips output to AMchips input pad (pipeline connection) [TO-DO]**

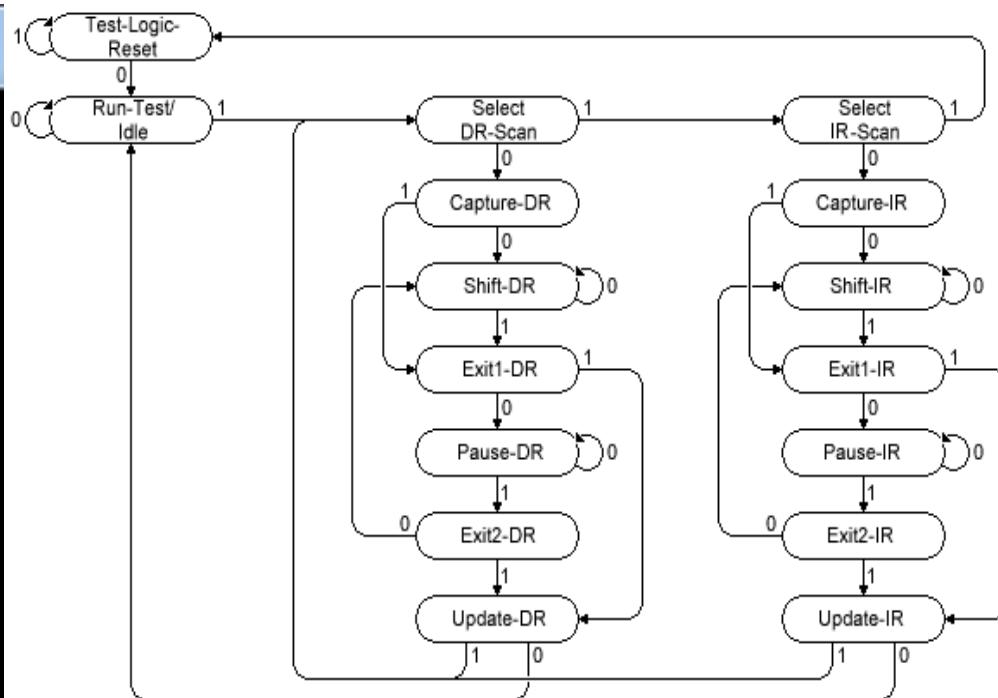
LAMB JTAG Testing

```
ftk@pcftkvmel1:~/testDaniel/ftk_v2/ftk_amb_ftk/src/low
#ifndef AM_JTAG_FUNC_H
#define AM_JTAG_FUNC_H

#include "ftkvmelib.h"
#include "ambftk_vme_regs.h"

int GotoTestReset(int amb_handle);
int GotoIdlefromReset(int amb_handle, int column);
int GotoShiftIRfromReset(int amb_handle, int column);
int GotoShiftIRfromIdle(int amb_handle, int column);
int GotoIdlefromExit1(int amb_handle, int column);
int GotoSelectDRfromExit1(int amb_handle, int column);
int StayIdle(int amb_handle);
int GotoShiftDRfromIdle(int amb_handle, int column);
int AMshift(int slave, int slot, u_int columns, u_int nwords, u_int* indata, u_int* outdata, int exit );
int ConfigureScam(int amb_handle, int slot, int chipno, int column, int scaminstruction, int gotoruntest);
int ConfigureChip(int amb_handle, int chipno, int column, int instruction);

#endif // AM_JTAG_FUNC_H
```



18,0-1

All

Monitoring and testing tools

- ▶ The Spybuffer is used to monitoring the data flow in each input and output link between AMBoard and AUX card
 - ▶ A function give this output file format

[illegible]

Monitoring and testing tools

- ▶ The Spybuffer is used to monitoring the data flow in each input and output link between AMBoard and AUX card
- ▶ A function give this output file format

```
[3e7] 0000 [3e7] 0000 [3e7] 0000 [3e7] 0000
[3e8] 0000 [3e8] 0000 [3e8] 0000 [3e8] 0000
[3e9] 0000 [3e9] 0000 [3e9] 0000 [3e9] 0000
[3ea] 0000 [3ea] 0000 [3ea] 0000 [3ea] 0000
[3eb] 0000 [3eb] 0000 [3eb] 0000 [3eb] 0000
[3ec] 0000 [3ec] 0000 [3ec] 0000 [3ec] 0000
[3ed] 0000 [3ed] 0000 [3ed] 0000 [3ed] 0000
[3ee] 0000 [3ee] 0000 [3ee] 0000 [3ee] 0000
[3ef] 0000 [3ef] 0000 [3ef] 0000 [3ef] 0000
[3f0] 0000 [3f0] 0000 [3f0] 0000 [3f0] 0000
[3f1] 0000 [3f1] 0000 [3f1] 0000 [3f1] 0000
[3f2] 0000 [3f2] 0000 [3f2] 0000 [3f2] 0000
[3f3] 0000 [3f3] 0000 [3f3] 0000 [3f3] 0000
[3f4] 0000 [3f4] 0000 [3f4] 0000 [3f4] 0000
[3f5] 0000 [3f5] 0000 [3f5] 0000 [3f5] 0000
[3f6] 0000 [3f6] 0000 [3f6] 0000 [3f6] 0000
[3f7] 0000 [3f7] 0000 [3f7] 0000 [3f7] 0000
[3f8] 0000 [3f8] 0000 [3f8] 0000 [3f8] 0000
[3f9] 0000 [3f9] 0000 [3f9] 0000 [3f9] 0000
[3fa] 0000 [3fa] 0000 [3fa] 0000 [3fa] 0000
[3fb] 0000 [3fb] 0000 [3fb] 0000 [3fb] 0000
[3fc] 0000 [3fc] 0000 [3fc] 0000 [3fc] 0000
[3fd] 0000 [3fd] 0000 [3fd] 0000 [3fd] 0000
[3fe] 0000 [3fe] 0000 [3fe] 0000 [3fe] 0000

SCT SPY STATUS
ISPY : 000(- f) ISPY : 000(- f) ISPY : 000(-
PIXEL SPY STATUS
ISPY : 000(- f) ISPY : 000(- f) ISPY : 000(-
[pcftkvme1] /home/ftk/testDaniel/ftk v2/ftk
```

In the red box is report the output of one Spybuffer:

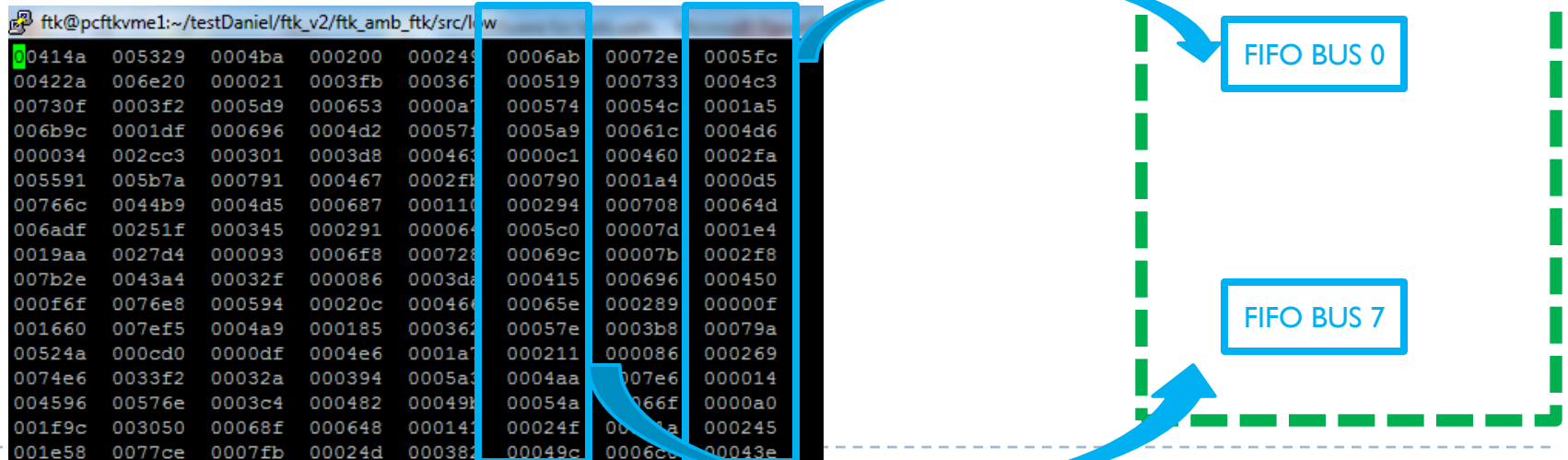
- address of memory location
- value of the memory

In the green box the are the information of the status of Spybuffer

- first free address location
- overflow status
- freeze status

Monitoring and testing tools

- ▶ The Spybuffer is used to monitoring the data flow in each input and output link between AMBoard and AUX card
 - ▶ A function give this output file format
- ▶ The VmeFifos are instantiate in each link for the input and output to simulate the eternal data flow
 - ▶ An hit file is loading into the FIFOs



Automatic test

- ▶ An automatic script is implemented to testing the entire system using tools describe above
- ▶ The list of operation
 - ▶ A simulation functions generate the **pattern bank** and both the **hit files** and the **expected road files**
 - ▶ The **hit file is loading** into the **VmeFifos**
 - ▶ A start command is sent to enable the hit distribution to the AMchip
 - ▶ The **output road** from the AMchip is stored into the output **Spybuffer**
 - ▶ The **content** of the **Spybuffer** is compared with the **expected road file**